



# POWER-MOS FET

## FIELD EFFECT POWER TRANSISTOR

**IRFF220,221**

3.5 AMPERES  
200, 150 VOLTS  
 $R_{DS(ON)} = 0.8 \Omega$

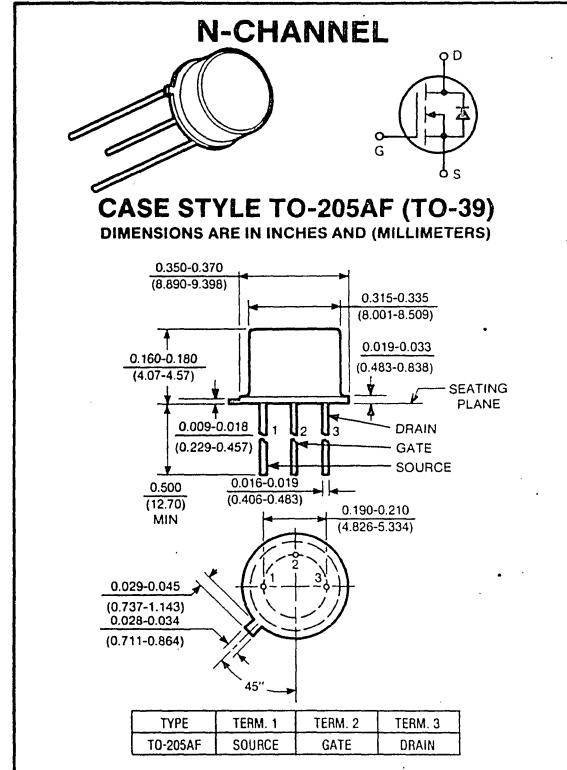
Preliminary

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

### Features

- Polysilicon gate — Improved stability and reliability
- No secondary breakdown — Excellent ruggedness
- Ultra-fast switching — Independent of temperature
- Voltage controlled — High transconductance
- Low input capacitance — Reduced drive requirement
- Excellent thermal stability — Ease of paralleling



maximum ratings ( $T_C = 25^\circ\text{C}$ ) (unless otherwise specified)

| RATING  | SYMBOL         | IRFF220    | IRFF221    | UNITS                              |
|---|----------------|------------|------------|------------------------------------|
| Drain-Source Voltage  | $V_{DSS}$      | 200        | 150        | Volts                              |
| Drain-Gate Voltage, $R_{GS} = 1\text{M}\Omega$  | $V_{DGR}$      | 200        | 150        | Volts                              |
| Continuous Drain Current @ $T_C = 25^\circ\text{C}$                                   | $I_D$          | 3.5        | 3.5        | A                                  |
| Pulsed Drain Current <sup>(1)</sup>   | $I_{DM}$       | 14         | 14         | A                                  |
| Gate-Source Voltage   | $V_{GS}$       | $\pm 20$   | $\pm 20$   | Volts                              |
| Total Power Dissipation @ $T_C = 25^\circ\text{C}$<br>Derate Above $25^\circ\text{C}$ | $P_D$          | 20<br>1.6  | 20<br>1.6  | Watts<br>$\text{W}/^\circ\text{C}$ |
| Operating and Storage<br>Junction Temperature Range                                   | $T_J, T_{STG}$ | -55 to 150 | -55 to 150 | $^\circ\text{C}$                   |

### thermal characteristics

|  |                 |      |      |                           |
|--|-----------------|------|------|---------------------------|
| Thermal Resistance, Junction to Case   | $R_{\theta JC}$ | 6.25 | 6.25 | $^\circ\text{C}/\text{W}$ |
| Thermal Resistance, Junction to Ambient  | $R_{\theta JA}$ | 175  | 175  | $^\circ\text{C}/\text{W}$ |
| Maximum Lead Temperature for Soldering<br>Purposes: 1/16" from Case for 10 Seconds | $T_L$           | 260  | 260  | $^\circ\text{C}$          |

(1) Repetitive Rating: Pulse width limited by max. junction temperature.

# electrical characteristics ( $T_C = 25^\circ C$ ) (unless otherwise specified)

| CHARACTERISTIC  | SYMBOL             | MIN          | TYP    | MAX         | UNIT  |
|---|--------------------|--------------|--------|-------------|-------|
| <b>off characteristics</b>  |                    |              |        |             |       |
| Drain-Source Breakdown Voltage<br>( $V_{GS} = 0V$ , $I_D = 250 \mu A$ )   | IRFF220<br>IRFF221 | BVDSS<br>150 | 200    | —           | Volts |
| Zero Gate Voltage Drain Current<br>( $V_{DS} = \text{Max Rating}$ , $V_{GS} = 0V$ , $T_C = 25^\circ C$ )<br>( $V_{DS} = \text{Max Rating} \times 0.8$ , $V_{GS} = 0V$ , $T_C = 125^\circ C$ ) |                    | IDSS         | —<br>— | 250<br>1000 | μA    |
| Gate-Source Leakage Current<br>( $V_{GS} = \pm 20V$ )   |                    | IGSS         | —      | ±100        | nA    |

## on characteristics\*

|  |                    |              |     |   |     |       |
|--|--------------------|--------------|-----|---|-----|-------|
| Gate Threshold Voltage<br>( $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$ )          | $T_C = 25^\circ C$ | $V_{GS(TH)}$ | 2.0 | — | 4.0 | Volts |
| On-State Drain Current<br>( $V_{GS} = 10V$ , $V_{DS} = 10V$ )                |                    | $I_{D(ON)}$  | 3.5 | — | —   | A     |
| Static Drain-Source On-State Resistance<br>( $V_{GS} = 10V$ , $I_D = 2.0A$ ) |                    | $R_{DS(ON)}$ | —   | — | 0.8 | Ohms  |
| Forward Transconductance<br>( $V_{DS} = 10V$ , $I_D = 2.0A$ )                |                    | $g_{fs}$     | 1.2 | — | —   | mhos  |

## dynamic characteristics

|                              |                |           |   |   |     |    |
|------------------------------|----------------|-----------|---|---|-----|----|
| Input Capacitance            | $V_{GS} = 10V$ | $C_{iss}$ | — | — | 600 | pF |
| Output Capacitance           | $V_{DS} = 25V$ | $C_{oss}$ | — | — | 300 | pF |
| Reverse Transfer Capacitance | $f = 1 MHz$    | $C_{rss}$ | — | — | 80  | pF |

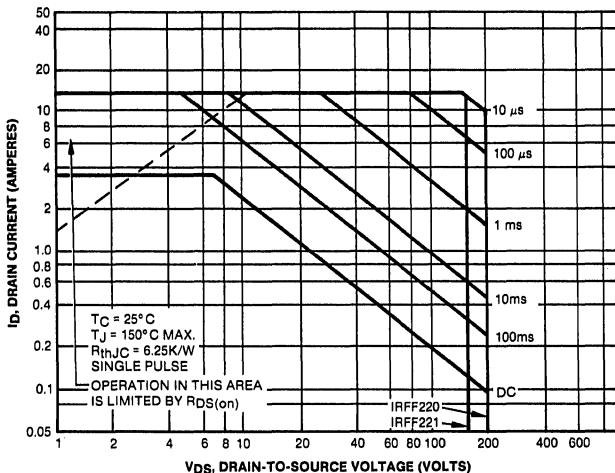
## switching characteristics\*

|                     |  |              |   |    |   |    |
|---------------------|--|--------------|---|----|---|----|
| Turn-on Delay Time  | $V_{DS} = 90V$                               | $t_{d(on)}$  | — | 20 | — | ns |
| Rise Time           | $I_D = 2.0A$ , $V_{GS} = 15V$                | $t_r$        | — | 30 | — | ns |
| Turn-off Delay Time | $R_{GEN} = 50\Omega$ , $R_{GS} = 12.5\Omega$ | $t_{d(off)}$ | — | 50 | — | ns |
| Fall Time           | ( $R_{GS}$ (EQUIV.) = $10\Omega$ )           | $t_f$        | — | 30 | — | ns |

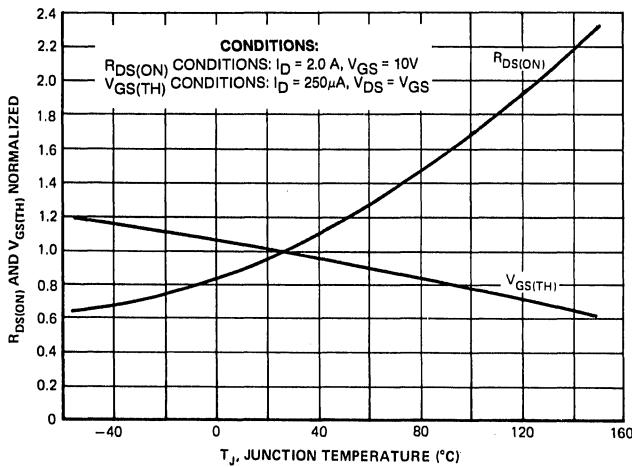
## source-drain diode ratings and characteristics\*

|  |                      |        |            |        |               |
|--|----------------------|--------|------------|--------|---------------|
| Continuous Source Current  | $I_S$                | —      | —          | 3.5    | A             |
| Pulsed Source Current  | $I_{SM}$             | —      | —          | 14     | A             |
| Diode Forward Voltage<br>( $T_C = 25^\circ C$ , $V_{GS} = 0V$ , $I_S = 3.5A$ )             | $V_{SD}$             | —      | —          | 2.0    | Volts         |
| Reverse Recovery Time<br>( $I_S = 3.5A$ , $dI_S/dt = 100A/\mu sec$ , $T_C = 125^\circ C$ ) | $t_{rr}$<br>$Q_{RR}$ | —<br>— | 350<br>2.3 | —<br>— | ns<br>$\mu C$ |

\*Pulse Test: Pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$



MAXIMUM SAFE OPERATING AREA



TYPICAL NORMALIZED R<sub>DS(ON)</sub> AND V<sub>GS(TH)</sub> VS. TEMP.